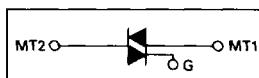


Triacs

Silicon Bidirectional Thyristors

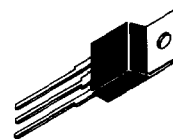
... designed for full-wave ac control applications primarily in industrial environments needing noise immunity.

- Guaranteed High Commutation Voltage
dv/dt — 500 V/ μ s Min @ $T_C = 25^\circ\text{C}$
- High Blocking Voltage — V_{DRM} to 800 V
- Photo Glass Passivated Junction for Improved Power Cycling Capability and Reliability



MAC321 Series

TRIACs
20 AMPERES RMS
200 thru 800 VOLTS



CASE 221A-04
(TO-220AB)
STYLE 4

MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage, Note 1 ($T_J = -40$ to $+125^\circ\text{C}$, 1/2 Sine Wave 50 to 60 Hz, Open Gate)	V_{DRM}		Volts
MAC321-4		200	
MAC321-6		400	
MAC321-8		600	
MAC321-10		800	
Peak Gate Voltage	V_{GM}	10	Volts
On-State Current RMS ($T_C = +75^\circ\text{C}$ Full Cycle Sine Wave 50 to 60 Hz)	$I_T(\text{RMS})$	20	Amp
Peak Surge Current (One Full Cycle, 60 Hz, $T_C = +75^\circ\text{C}$ preceded and followed by Rated Current)	I_{TSM}	150	Amp
Circuit Fusing Considerations ($t = 8.3$ ms)	I^2t	93	A^2s
Peak Gate Power ($T_C = +75^\circ\text{C}$, Pulse Width = 2.0 μ s)	P_{GM}	20	Watts
Average Gate Power ($T_C = +75^\circ\text{C}$, $t = 8.3$ ms)	$P_{G(AV)}$	0.5	Watt
Peak Gate Current	I_{GM}	2.0	Amp
Operating Junction Temperature Range	T_J	-40 to +125	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-40 to +150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.8	$^\circ\text{C}/\text{W}$

Note 1. V_{DRM} for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

Devices listed in bold, italic are Motorola preferred devices.

MAC321 Series

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
Peak Blocking Current ($V_D = \text{Rated } V_{DRM}, \text{ Gate Open}$) $T_J = 25^\circ\text{C}$ $T_J = +125^\circ\text{C}$	I_{DRM}	— —	— —	10 2.0	μA mA
Peak On-State Voltage (Either Direction) ($I_{TM} = 28 \text{ A Peak}; \text{ Pulse Width } \leq 2.0 \text{ ms}, \text{ Duty Cycle } \leq 2.0\%$)	V_{TM}	—	1.4	1.7	Volts
Gate Trigger Current (Continuous dc) (Main Terminal Voltage = 12 Vdc, $R_L = 100 \text{ Ohms}$) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	I_{GT}	— — —	— — —	100 100 100	mA
Gate Trigger Voltage (Continuous dc) (Main Terminal Voltage = 12 Vdc, $R_L = 100 \text{ Ohms}$) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-) (Main Terminal Voltage = Rated $V_{DRM}, R_L = 10 \text{ k}\Omega, T_J = +125^\circ\text{C}$) MT2(+), G(+); MT2(-), G(-); MT2(+), G(-)	V_{GT}	— — — 0.2	— — — —	2.0 2.0 2.0 —	Volts
Holding Current (Either Direction) (Main Terminal Voltage = 12 Vdc, Gate Open, Initiating Current = 200 mA)	I_H	—	—	100	mA
Turn-On Time ($V_D = \text{Rated } V_{DRM}, I_{TM} = 28 \text{ A}, I_{GT} = 120 \text{ mA},$ Rise Time = $0.1 \mu\text{s}$, Pulse Width = $2.0 \mu\text{s}$)	t_{gt}	—	1.5	—	μs
Critical Rate of Rise of Off-State Voltage ($V_D = \text{Rated } V_{DRM}, \text{ Exponential Voltage Rise, Gate Open}$) $T_J = 25^\circ\text{C}$ $T_J = +125^\circ\text{C}$	$dv/dt(s)$	500 200	— —	— —	$\text{V}/\mu\text{s}$

3

TYPICAL CHARACTERISTICS

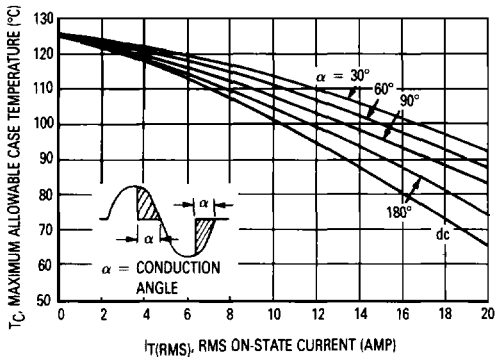


Figure 1. RMS Current Derating

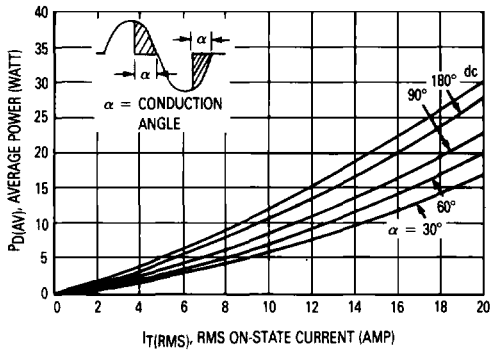


Figure 2. On-State Power Dissipation

MAC321 Series

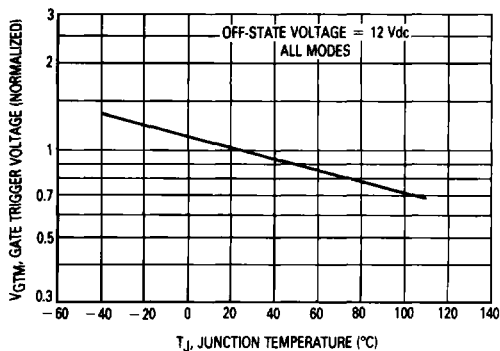


Figure 3. Typical Gate Trigger Voltage

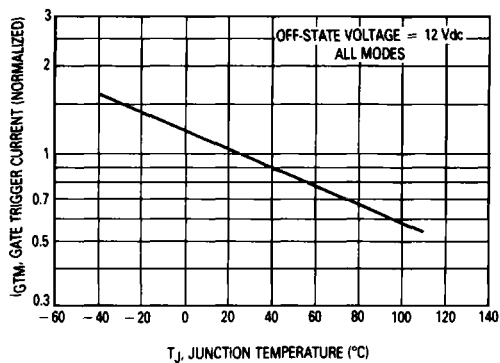


Figure 4. Typical Gate Trigger Current

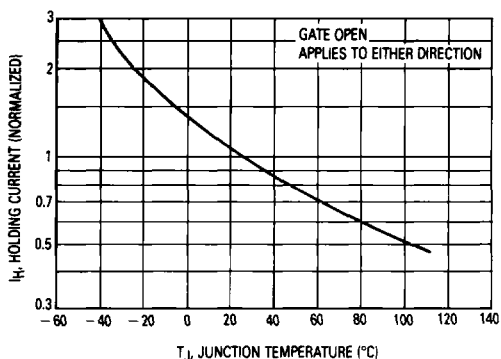


Figure 6. Typical Holding Current

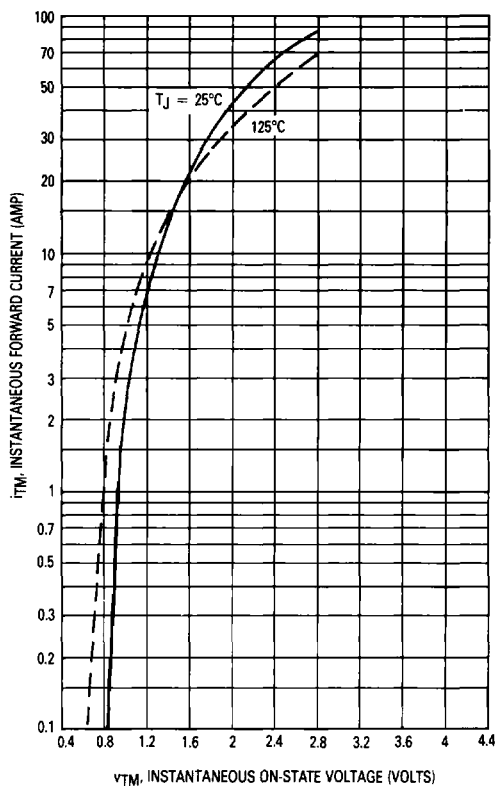


Figure 5. Maximum On-State Characteristics

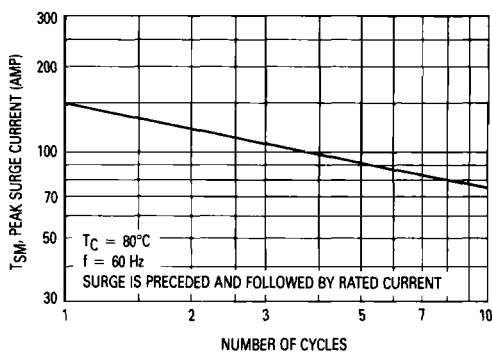


Figure 7. Maximum On-Repetitive Surge Current

MAC321 Series

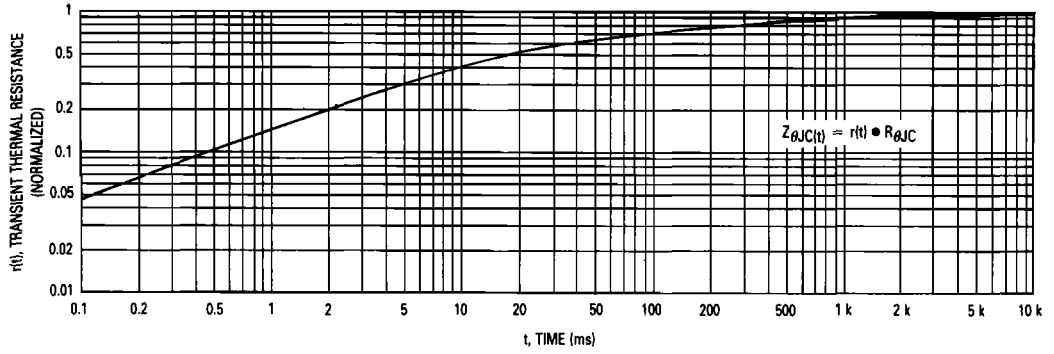


Figure 8. Thermal Response